IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of

:

Tsutomu IGAKI et al.

Mail Stop: PCT

Serial No. NEW

Attorney Docket No. 2005 1998A

Filed January 3, 2006

SURFACE ACOUSTIC WAVE FILTER [Corresponding to PCT/JP2004/011116 Filed July 28, 2004]

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

1a.

Pursuant to the provisions of 37 CFR 1.56, 1.97 and 1.98, Applicants request consideration of the references listed on attached form PTO-1449 and any additional information identified below in paragraph 3. A legible copy of each reference listed on the Form PTO-1449 is enclosed, except a copy is not provided for:

[]	each U.S. Patent and U.S. Patent application publication;
	each reference previously cited in the international application PCT/; and/or
	each reference previously cited in prior parent application Serial No.
[X] T	his Information Disclosure Statement is submitted:
	three months of the filing date (or of entry into the National Stage) of the entitled application, or

before the mailing of a first Office Action on the merits or the mailing of a first Office Action after the filing of an RCE,

and thus no certification and/or fee is required.

1b.	П	This	Inform	ation	Disc	losure	Statemer	ıt is	submitted

after the events of above paragraph 1a and prior to the mailing date of a final Office Action or a Notice of Allowance or an action which otherwise closes prosecution in the application, and thus:

- (1) [] the certification of paragraph 2 below is provided, or
- (2) [] the fee of \$180.00 specified in 37 CFR 1.17(p) is enclosed.

1c. [] This Information Disclosure Statement is submitted:

after the mailing date of a final Office Action or Notice of Allowance or action which otherwise closes prosecution in the application, and prior to payment of the issue fee, and thus:

the certification of paragraph 2 below is provided, and

the fee of \$180.00 specified in 37 CFR 1.17(p) is enclosed.

2. It is hereby certified

- a. [] that each item of information contained in this Information Disclosure

 Statement was first cited in any communication from a foreign patent office in a

 counterpart foreign application not more than three months prior to the filing of
 the Statement, or
- b. [] that no item of information contained in the Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application and, to the knowledge of the person signing the certification after making reasonable inquiry, was known to any individual designated in §1.56(c) more than three months prior to the filing of the Statement.
- 3. [] Consideration of the following list of additional information (including any copending or abandoned U.S. application, prior uses and/or sales, etc.) is requested.

- 4. For each non-English language reference listed on the attached form PTO-1449, reference is made to:
 - a. [] a full or partial English language translation submitted herewith,
 - b. [X] the International Search Report (in the English language) submitted herewith,
 - c. [X] the concise explanation contained in the specification of the present application at page 1,
 - d. [X] the concise explanation set forth in the attached English language abstract,
 - e. [] the concise explanation set forth below or on a separate sheet attached to the reference:
- 5. [] A foreign patent office search report citing one or more of the references is enclosed.

Respectfully submitted,

Tsutomu IGAKI et al.

By Charles R. Watts

Registration No. 33,142 Attorney for Applicants

CRW/asd Washington, D.C. 20006-1021 Telephone (202) 721-8200 Facsimile (202) 721-8250 January 3, 2006

Sheet 1 of 1	1		INFORMA	TION DISCLOSURE STATEMEN	TIAP1	5 Rec	'd PCT/PT	0 03 J	AN 200
FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S)				ATTY DOCKET NO. 2005_1998A		SERIAL NEW	NO. 10 /!	5632	81
				APPLICANT Tsutomu IGAKI et al.					
		ral sheets if necessary) d to PTO: January 3, 20	FILING DATE January 3, 2006			GROUP			
			U.:	S. PATENT DOCUMENTS					
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	С	LASS	SUBCLASS	FILING DA	
	AA								
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			FORE	EIGN PATENT DOCUMENTS					
		DOCUMENT NUMBER	DATE	COUNTRY	С	LASS	SUBCLASS	TRANSL/ YES	ATION NO
	АН	8-265099	10/1996	JP				Abstract	
· · · · · · · · · · · · · · · · · · ·	AI	10-261932	9/1998	JP				Abstract	
	AJ	2002-016470	1/2002	JP				Abstract	
	AK	2003-174350	6/2003	JP				Abstract	
	AL	9-505974	6/1997	JP				Abstract	
	AM	5-183380	7/1993	JP				Abstract	
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		OTHER	DOCUMENT(S) (I	Including Author, Title, Date, Perti	nent Page:	s, Etc.)			
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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copthis form with next communication to applicant.